

<b>Notice of References Cited</b>	Application/Control No. 10/505,194	Applicant(s)/Patent Under Reexamination MIURA ET AL.	
	Examiner Adam R. Giesy	Art Unit 2627	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2005/0073930 A1	04-2005	Lee et al.	369/059.11
*	B	US-6,345,026 B1	02-2002	Furukawa et al.	369/59.11
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	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

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